

Search Notes

Application/Control No.

10/620,001

Examiner

Richard K. Lee

Applicant(s)/Patent under
Reexamination

WONG ET AL.

Art Unit

2832

SEARCHED

Class	Subclass	Date	Examiner
200	61.45M	12/15/2005	KL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR